



### • General Description

It combines planar MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . It is suitable for automotive application.

### • Features

- AEC-Q101 Qualified
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

### • Application

- BLDC Motor driver
- DC-DC
- Load Switch

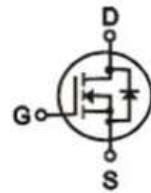
### • Ordering Information:

Part NO.	ZMPA026N06C
Marking	ZMP026N06
Packing Information	BULK TUBE
Basic ordering unit (pcs)	400

### • Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ )

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	$V_{DS}$		60	V
Gate-Source Voltage	$V_{GS}$		$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ\text{C}$	205	A
	$I_D$	$T_C=75^\circ\text{C}$	167	A
	$I_D$	$T_C=100^\circ\text{C}$	145	A
Pulsed Drain Current <sup>①</sup>	$I_{DM}$	Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$	820	A
Total Power Dissipation	$P_D$	$T_C=25^\circ\text{C}$	375	W
Total Power Dissipation	$P_D$	$T_A=25^\circ\text{C}$	2.4	W
Operating Junction Temperature	$T_J$		-55 to +175	$^\circ\text{C}$
Storage Temperature	$T_{STG}$		-55 to +175	$^\circ\text{C}$
Single Pulse Avalanche Energy	$E_{AS}$	$L=0.1\text{mH}$ , $VGS=10\text{V}$ , $R_g=25\Omega$ ,	361	mJ
		$L=0.5\text{mH}$ , $VGS=10\text{V}$ , $R_g=25\Omega$ ,	650	mJ
ESD Level (HBM)			CLASS 2	

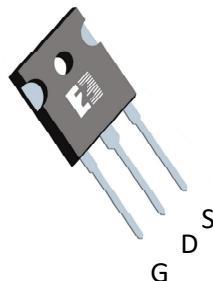
### • Product Summary



$V_{DS}= 60\text{V}$

$R_{DS(ON)} = 2.6\text{m}\Omega$

$I_D = 205\text{A}$



TO-247



HF

**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R <sub>thJC</sub>		-	0.4	°C/W
Thermal resistance, junction-ambient	R <sub>thJA</sub>		-	62	°C/W
Soldering temperature (total time<10s)	T <sub>sold</sub>		-	260	°C

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	60			V
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.2	1.8	2.5	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> = 60V			1.0	uA
Gate- Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> = 0V			100	nA
Static Drain-source On Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> = 20A		2.6	3.3	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> = 20A		3.5	4.6	mΩ
Forward Transconductance	g <sub>FS</sub>	V <sub>GS</sub> =5V, I <sub>SD</sub> = 10A		142		S
Diode Forward Voltage	V <sub>FSD</sub>	V <sub>GS</sub> =0V, I <sub>SD</sub> = 20A			1.3	V

**•Dynamic characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C <sub>iss</sub>	f = 1MHz, V <sub>DS</sub> =25V	-	9431	-	pF
Output capacitance	C <sub>oss</sub>		-	2262	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	715	-	
Gate Resistance	R <sub>g</sub>	f = 1MHz	-	1.6		Ω
Total gate charge	Q <sub>g</sub>	V <sub>DD</sub> = 15V, I <sub>D</sub> = 20A, V <sub>GS</sub> = 10V	-	296	-	nC
Gate - Source charge	Q <sub>gs</sub>		-	27	-	
Gate - Drain charge	Q <sub>gd</sub>		-	80	-	
Turn-ON Delay time	t <sub>D(on)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>G</sub> =3.3Ω, I <sub>D</sub> =20A	-	17	-	ns
Turn-ON Rise time	t <sub>r</sub>		-	80	-	ns
Turn-Off Delay time	t <sub>D(off)</sub>		-	52	-	ns
Turn-Off Fall time	t <sub>f</sub>		-	81	-	ns
Reverse Recovery Time	t <sub>rr</sub>	V <sub>DD</sub> =20V, dI <sub>S</sub> /dt = 100A/us, I <sub>S</sub> =20A	-	30	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>		-	40	-	nC



Fig.1 Gate-Charge Characteristics

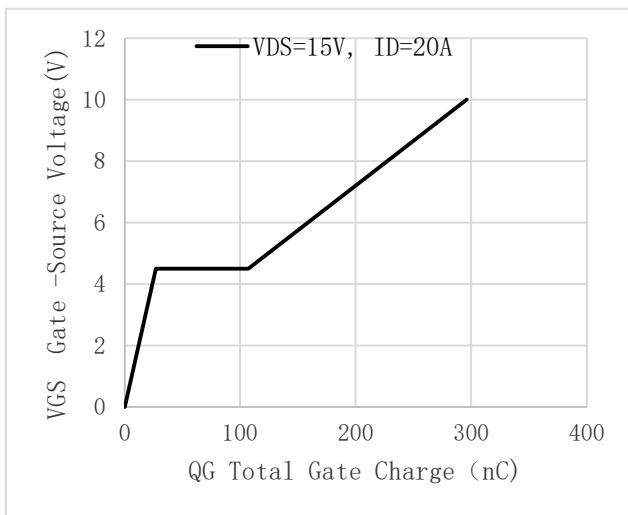


Fig.2 Capacitance Characteristics

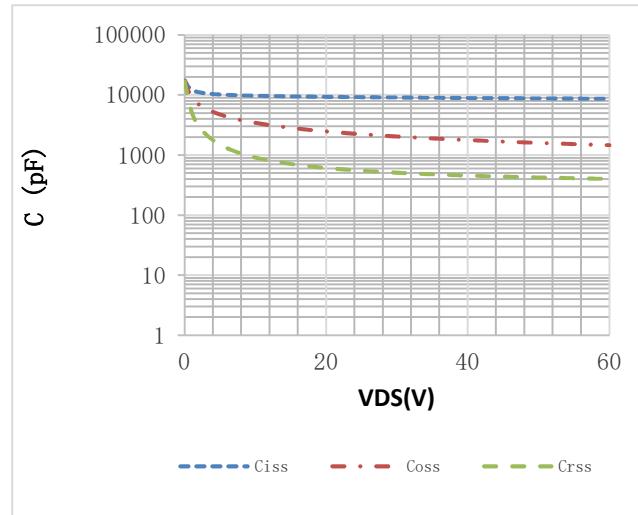


Fig.3 Power Dissipation

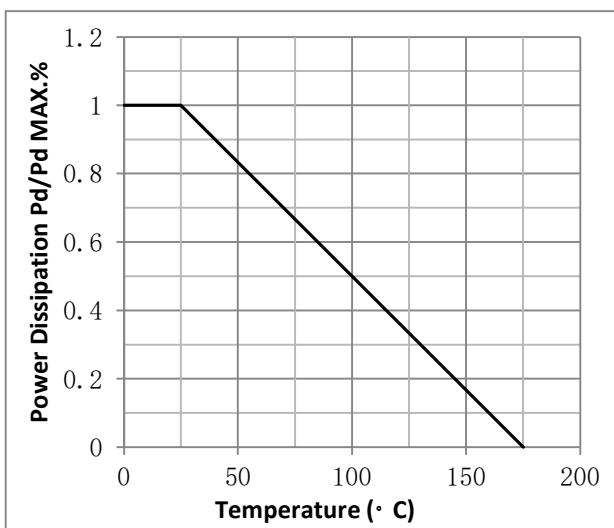


Fig.4 Typical output Characteristics

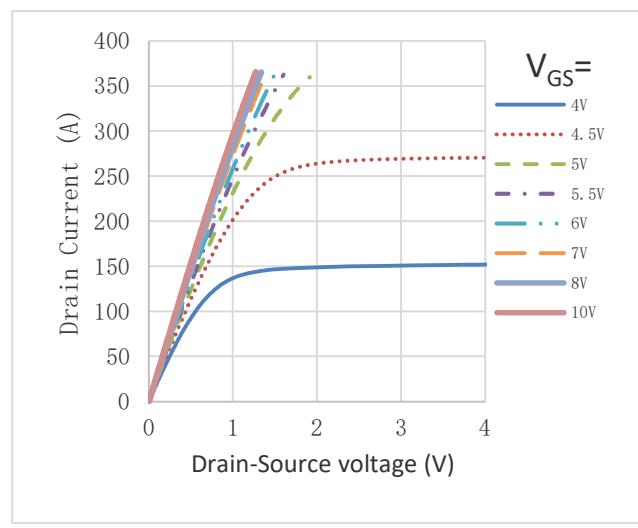


Fig.5 Threshold Voltage V.S Junction Temperature

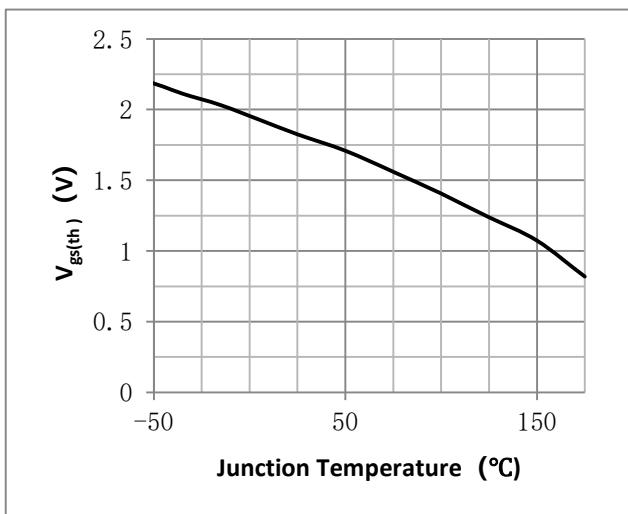


Fig.6 Resistance V.S Drain Current

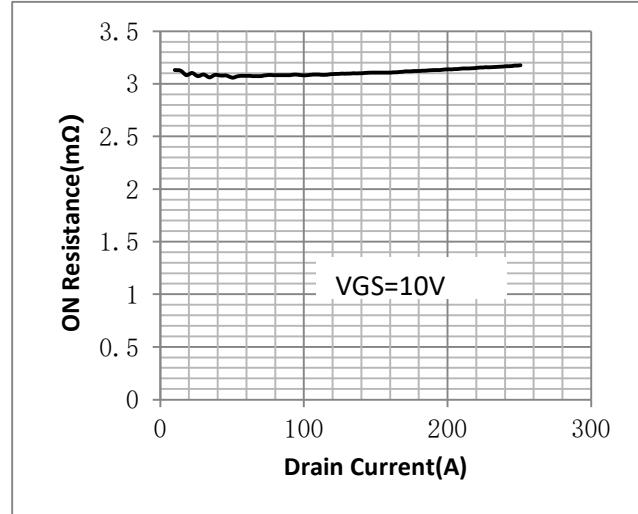


Fig.7 On-Resistance VS Gate Source Voltage

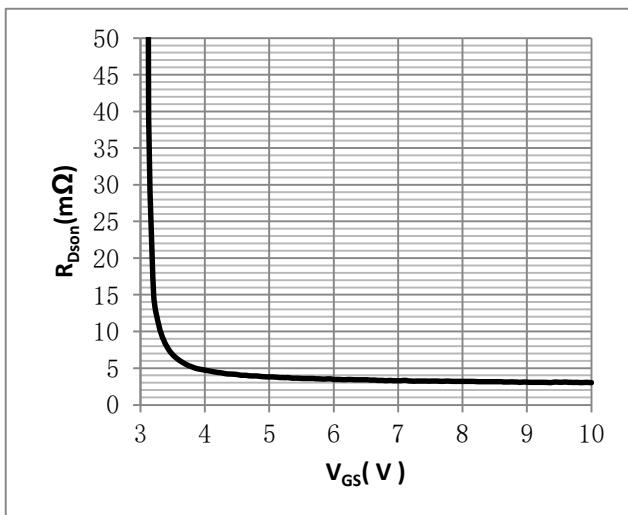


Fig.8 On-Resistance V.S Junction Temperature

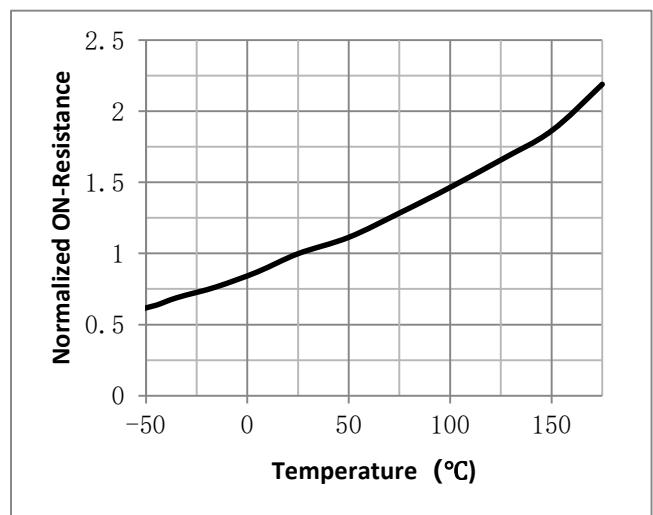


Figure 9. Diode Forward Voltage vs. Current

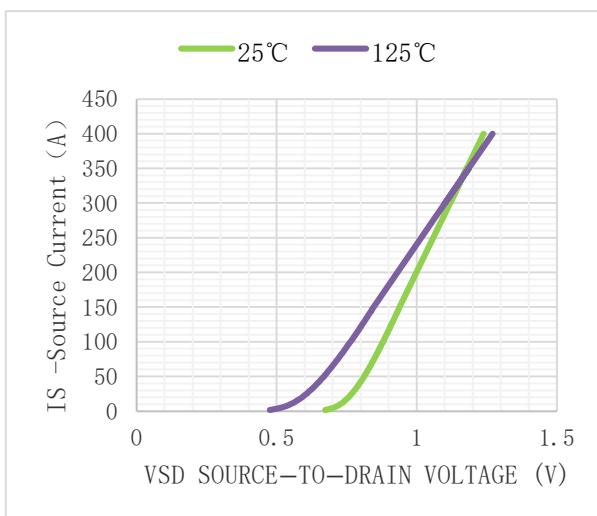


Figure 10. Transfer Characteristics

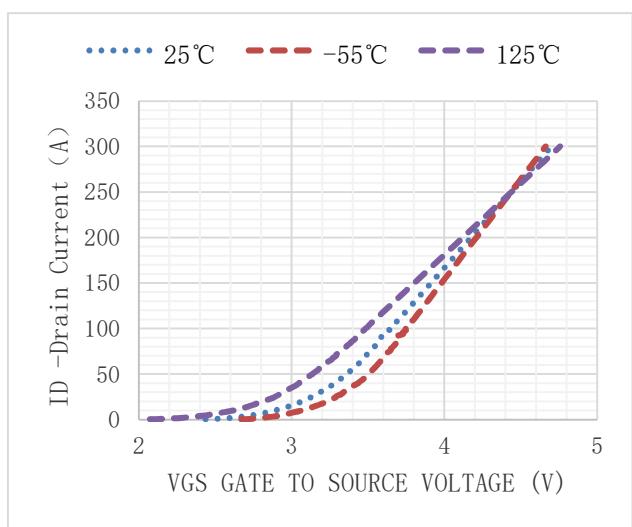


Fig.11 SOA Maximum Safe Operating Area

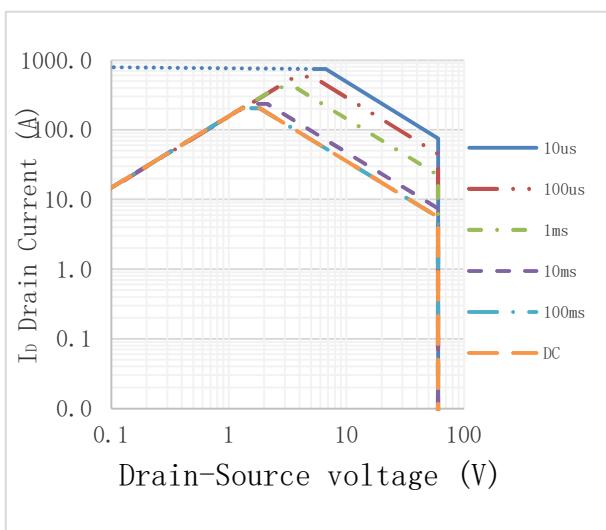
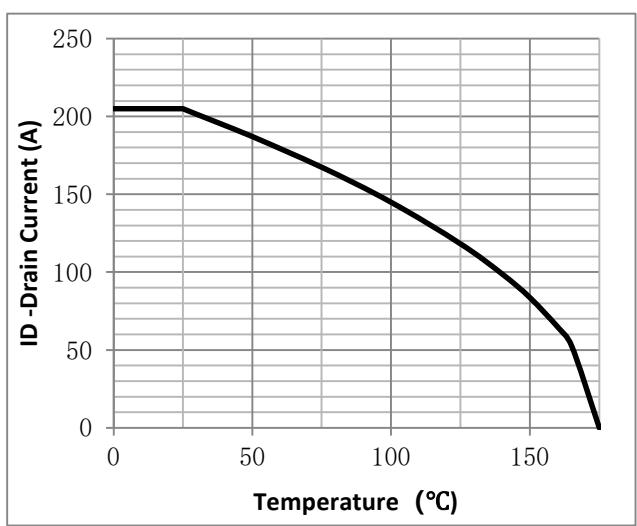
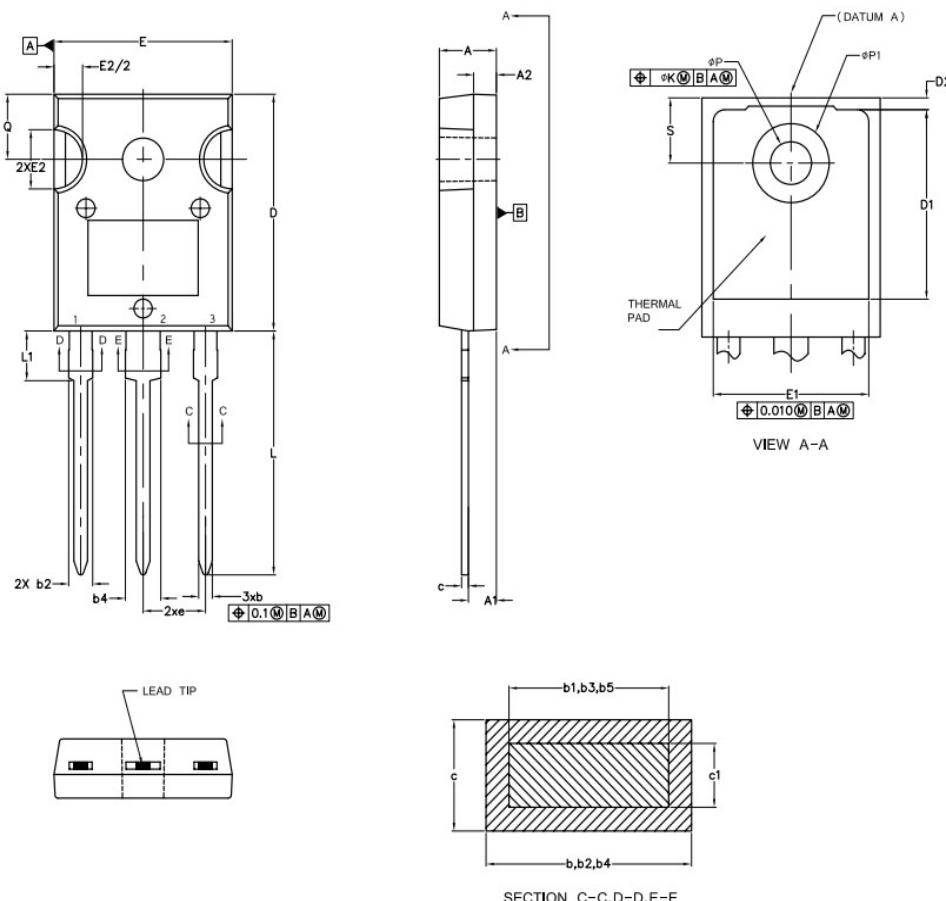


Fig.12 ID vs. Junction Temperature②



**•TO-247 Package Outline**


SYMBOLS	DIMENSIONS			
	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A	4.83	5.13	0.190	0.20
A1	2.21	2.59	0.087	0.102
A2	1.50	2.49	0.059	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.65	2.39	0.065	0.094
b3	1.65	2.34	0.065	0.092
b4	2.59	3.43	0.102	0.135
b5	2.59	3.38	0.102	0.133
c	0.38	0.89	0.015	0.035
c1	0.38	0.84	0.015	0.033
D	19.71	20.70	0.776	0.815
D1	13.08	—	0.515	—
D2	0.51	1.35	0.020	0.053
E	15.29	15.87	0.602	0.625
E1	13.46	—	0.530	—
E2	4.52	5.49	0.178	0.216
e	5.46BSC	—	0.215BSC	—
L	19.57	21.00	0.780	0.827
L1	3.71	4.29	0.146	0.169
φP	3.56	3.66	0.140	0.144
φP1	—	7.39	—	0.291
Q	5.31	5.69	0.209	0.224
S	5.51BSC	—	0.217BSC	—

**Note:**

① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

② Practically the current will be limited by PCB, thermal design and operating temperature.  $V_{GS}=10V$ .

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## Revision History

Version	Date	Change
A	2024/8/15	New
B	2025/5/24	Correct POD